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	LIST	OF PRIOR ART CI	TED	AUS920030556US1 107	757,197		
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	٠.			APPLICANT DeWitt, Jr. et al.	•		
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E.		9	REL	ATED PATENT APPLICATIONS			11
EXAM		APPLICATION NO./	APPLICANT	TITLE			ILING
SGN	AA	ATTY. DOCKET NO. 10/675,777 /	DeWitt, Jr. et al.	Method and Apparatus for Counting Instruction Execution	cution and		0, 2003
SGN	AB	AUS920030477US1 10/674,604 /	DeWitt, Jr. et al.	Data Accesses Method and Apparatus for Selectively Counting Instr			0, 2003
	AC	AUS920030478US1 10/675,831 /	DeWitt, Jr. et al.	Data Accesses			
SGN		AUS920030479US1		Method and Apparatus for Generating Interrupts Upo of Marked Instructions and Upon Access to Marked I Locations	Memory	Sep. 3	0, 2003
SGN	AD	10/675,778 / AUS920030480US1	DeWitt, Jr. et al.	Method and Apparatus for Counting Data Accesses a Instruction Executions that Exceed a Threshold	and	Sep. 3	0, 2003
SGN	AE	10/675,776 / AUS920030481US1	DeWitt, Jr. et al.	Method and Apparatus for Counting Execution of Sp Instructions and Accesses to Specific Data Location	ecific s	Sep. 3	0, 2003
SGN	AF	10/675,751 / AUS920030482US1	DeWitt, Jr. et al.	Method and Apparatus for Debug Support for Individ Instructions and Memory Locations		Sep. 3	0, 2003
SGN	AG	10/675,721 / AUS920030483US1	Levine et al.	Method and Apparatus to Autonomically Select Instr Selective Counting	uctions for	Sep. 3	0, 2003
SGN	AH	10/674,642 / AUS920030484US1	Levine et al.	Method and Apparatus to Autonomically Count Instri Execution for Applications	uction	Sep. 3	0, 2003
SGN	Al	10/674,606 / AUS920030485US1	Levine et al.	Method and Apparatus to Autonomically Take an Exc Specified Instructions	ecution on	Sep. 3	0, 2003
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SGN	AK	10/675,872 / AUS920030487US1	DeWitt, Jr. et al.	Method and Apparatus for Counting Instruction and Location Ranges	Memory	Sep. 3	0, 2003
SGN	AL	10/757,250 / AUS920030488US1	Levine et al.	Method and Apparatus for Maintaining Performance Structures in a Page Table for use in Monitoring Perf Computer Program	Monitoring formance of a	Jan. 1	4, 2004
SGN	AM	10/757,186 / AUS920030540US1	DeWitt, Jr. et al.	Method and Apparatus for Qualifying Collection of P Monitoring Events by Types of Interrupt when Interru	erformance	Jan. 1	4, 2004
SGN	AN	10/757,198 / AUS920030541US1	DeWitt, Jr. et al.	Method and Apparatus for Counting Interrupts by Ty		Jan. 1	4, 2004
SGN	AO	10/757,192 / AUS920030543US1	DeWitt, Jr. et al.	Method and Apparatus for Providing Pre and Post Ha Recording Events	andlers for	Jan. 1	4, 2004
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SGN			DeWitt, Jr. et al.	Data Accesses to Identify Hot Spots Method and Apparatus for Autonomic Detection of C Tall' Conditions and Storage of Instructions/Data in	ache "Chase "Chase Tall"	Jan. 1	4, 2004
SGN	AR	10/757,269 / AUS920030549US1	DeWitt, Jr. et al.	Data Structure Method and Apparatus for Autonomically Initiating N of Secondary Metrics Based on Hardware Counter V	feasurement alues for	Jan. 1	4, 2004
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SGN	AX	AUS920030554US1 10/757,227 / AUS920030555US1	DeWitt, Jr. et al.	Method and Apparatus for Autonomically Moving Ca	che Entries to	Jan. 1	4, 2004
ATE CONS	DERE		L	Dedicated Storage when False Cache Line Sharing is EXAMINER /Samuel Neway/	s Detected		

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MAY 3 0 2006
INFORMATION DISCLOSURE
STATEMENT BY APPLICATION

Complete If Known

Application Number 10/757,197

Filing Date 01-14-2004

First Named Inventor DeWitt, Jr. et al.

Examiner Name Dam, Tuan Quang

Art Unit 2192 2/9/

Attorney Docket No. AUS920030556US1

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Date Considered:

08/29/2006

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Application Number	10/757,197					
Filing Date	01-14-2004					
First Named Inventor	DeWitt, Jr. et al.					
Examiner Name	Dam, Tuan Quang					
Art Unit	2192 2194					
Attorney Docket No.	AUS920030556US1					

Exam Initia	iiiei	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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/Samuel Neway/

Date Considered: 08/29/2006

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Application Number	10/757,197
Filing Date	01-14-2004
First Named Inventor	DeWitt, Jr. et al.
Examiner Name	Dam, Tuan Quang
Art Unit	2)192 2 94
Attorney Docket No.	AUS920030556US1

08/29/2006

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	Application Number	10757197
INTERPRETATION PRODUCTION	Filing Date	2004-01-14
INFORMATION DISCLOSURE	First Named Inventor	DeWitt, Jr. et al.
STATEMENT BY APPLICANT (Not for submission under 37 CFR 1.99)	Art Unit	2192 219U
	Examiner Name	Dam, Tuan Quang
	Attorney Docket Number	er AUS920030556US1

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Not for submission under 37 CFR 1.99)

Application Number	10757197
Filing Date	2004-01-14
First Named Inventor	DeWitt, Jr. et al.
Art Unit	2192 2194
Examiner Name	Dam, Tuan Quang
Attorney Docket Numb	er AUS920030556US1

Examiner Initials*	Examiner Cite (book, magazine, journal, serial, symposium, catalog, etc), date, pages(s), volume-issue number(s), publisher, city and/or country where published.					
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Examiner	Signa	ature /Samuel Neway/	Date Considered	08/29/2006		
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				APPLICANT DeWitt, Jr. et al.		
				FILING DATE	GROUP ART UNI	Not Assigned
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EXAMINER INITIAL		DOCUMENT NO.	PUBLICATION DATE	INVENTOR NAME	CLASS/ SUBCLASS	FILING DATE
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EXAMINER INITIAL		DOCUMENT NO.	PUBLICATION DATE	COUNTRY	SUBCLASS	YES	NO
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INITIAL	1	09/435,069	Davidson et al.	Method and Apparatus for Instructio Performance Monitoring and Debug	n Sampling for	Nov. 4	1999
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	Application Number	10757197
	Filing Date	2004-01-14
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STATEMENT BY APPLICANT (Not for submission under 37 CFR 1.99)	Art Unit	0222 2194
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